18. TEST PHOTOGRAPHS

See following Attached Pages for setup photographs.

FCC ID: A3LSMG960U	HAC (RF EMISSIONS) TEST REPORT		SAMSUNG	Approved by: Quality Manager
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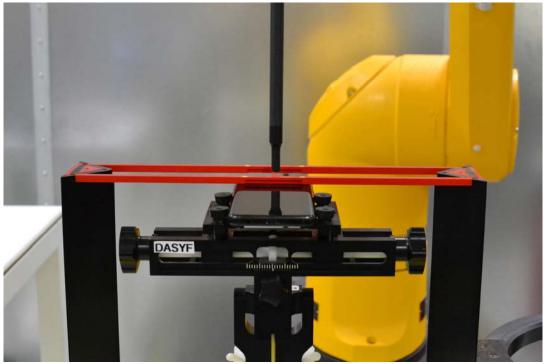


Figure 18-1 Ear Reference Point HAC Phantom Alignment

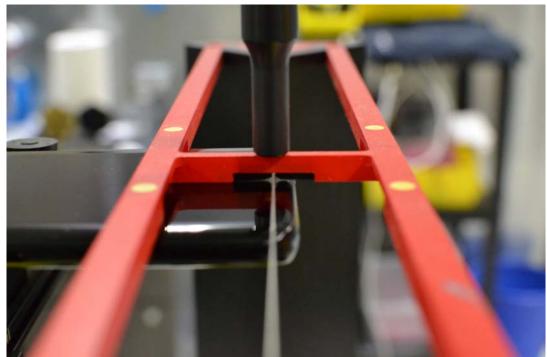
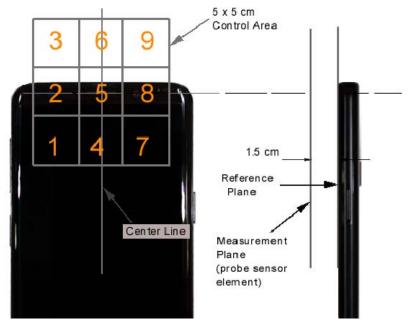


Figure 18-2 HAC Phantom Plane Alignment

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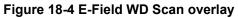
09/14/2017

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